# P-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	$R_{DS(on)}$ ( $\Omega$ )	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)			
- 30	0.0098 at V <sub>GS</sub> = 10 V	- 19.7	27 nC			
- 30	0.0165 at V <sub>GS</sub> = 4.5 V	- 15.2	27 110			

# SO-8 S 1 8 D S 2 7 D S 3 6 D G 4 5 D

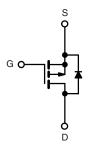
#### **FEATURES**

- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET® Power MOSFET
- 100 % R<sub>g</sub> Tested

# ROHS COMPLIANT HALOGEN FREE

#### **APPLICATIONS**

- Load Switches
  - Notebook PCs
  - Desktop PCs



P-Channel MOSFET

ABSOLUTE MAXIMUM RATIN	IGS 1A = 25 C,	uniess otherwis	se noteu	
Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V <sub>DS</sub>	- 30	V	
Gate-Source Voltage		V <sub>GS</sub>	± 20	V
	T <sub>C</sub> = 25 °C		- 19.7	
Continuous Dusin Comment (T., 150 °C)	T <sub>C</sub> = 70 °C		- 15.7	
Continuous Drain Current (T <sub>J</sub> = 150 °C)	T <sub>A</sub> = 25 °C	I <sub>D</sub>	- 13 <sup>b, c</sup>	
	T <sub>A</sub> = 70 °C		- 10.4 <sup>b, c</sup>	А
Pulsed Drain Current		I <sub>DM</sub>	- 50	
0 " 0 0 0 0	T <sub>C</sub> = 25 °C	1	- 4.7	
Continous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	I <sub>S</sub>	- 2.1 <sup>b, c</sup>	
	T <sub>C</sub> = 25 °C		5.7	
Manine on Device Discipation	T <sub>C</sub> = 70 °C		3.6	14/
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	2.5 <sup>b, c</sup>	W
	T <sub>A</sub> = 70 °C	1	1.6 <sup>b, c</sup>	
Operating Junction and Storage Temperatur	T <sub>J</sub> , T <sub>stq</sub>	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS							
Parameter		Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient <sup>b, d</sup>	t ≤ 10 s	$R_{thJA}$	35	50	°C/W		
Maximum Junction-to-Foot (Drain)	Steady State	$R_{thJF}$	18	22	]		

#### Notes

- a. Based on  $T_C = 25$  °C.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 10 s
- d. Maximum under Steady State conditions is 85 °C/W.



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	- 30			V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_J$ $I_D = -250 \mu A$			- 20		m\//°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	η = - 250 μΑ		4.9		mV/°C	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_D = -250 \mu A$	- 1.2		- 2.5	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zawa Cata Waltana Dunin Comment	I <sub>DSS</sub>	V <sub>DS</sub> = - 30 V, V <sub>GS</sub> = 0 V	0 V -		- 1	μА	
Zero Gate Voltage Drain Current		V <sub>DS</sub> = - 30 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C			- 5		
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \le -5 \text{ V}, V_{GS} = -10 \text{ V}$	- 30			Α	
Durin Orange On Olate Bestidens of	Б	V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 13 A			0.0098		
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 10 A		0.0137	0.0165	5 Ω	
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = - 15 V, I <sub>D</sub> = - 13 A		40		S	
Dynamic <sup>b</sup>				•	•		
Input Capacitance	C <sub>iss</sub>			2610		pF	
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = - 15 V, V <sub>GS</sub> = 0 V, f = 1 MHz		460			
Reverse Transfer Capacitance	C <sub>rss</sub>			395			
Tabal Oata Ohamus	Qg	V <sub>DS</sub> = - 15 V, V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 13 A		53	80	80 41 nC	
Total Gate Charge				27	41		
Gate-Source Charge	$Q_{gs}$	V <sub>DS</sub> = - 15 V, V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 13 A		8			
Gate-Drain Charge	Q <sub>gd</sub>			13			
Gate Resistance	$R_{g}$	f = 1 MHz	0.4	2.1	4.2	Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			52	78		
Rise Time	t <sub>r</sub>	$V_{DD} = -15 \text{ V}, R_{L} = 1.5 \Omega$		41	62	ns	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong$ - 10 A, $V_{GEN}$ = - 4.5 V, $R_g$ = 1 $\Omega$		36	54		
Fall Time	t <sub>f</sub>			15	25		
Turn-On Delay Time	t <sub>d(on)</sub>			12	20		
Rise Time	t <sub>r</sub>	$V_{DD} = -15 \text{ V}, R_{L} = 1.5 \Omega$		9	15		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong$ - 10 A, $V_{GEN}$ = - 10 V, $R_g$ = 1 $\Omega$		42	63		
Fall Time	t <sub>f</sub>			9	15		
Drain-Source Body Diode Characteristi	cs			•	•		
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			- 4.7	۸	
Pulse Diode Forward Current	I <sub>SM</sub>				- 50	А	
Body Diode Voltage	$V_{SD}$	I <sub>S</sub> = - 10 A, V <sub>GS</sub> = 0 V		- 0.8	- 1.2	٧	
Body Diode Reverse Recovery Time	t <sub>rr</sub>	I <sub>F</sub> = - 10 A, dl/dt = 100 A/μs, T <sub>.1</sub> = 25 °C		20	30	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			10	20	nC	
Reverse Recovery Fall Time	t <sub>a</sub>	$\frac{1}{1} = \frac{1}{1} = \frac{1}$		10		ns	
Reverse Recovery Rise Time	t <sub>b</sub>	7		9		ns	

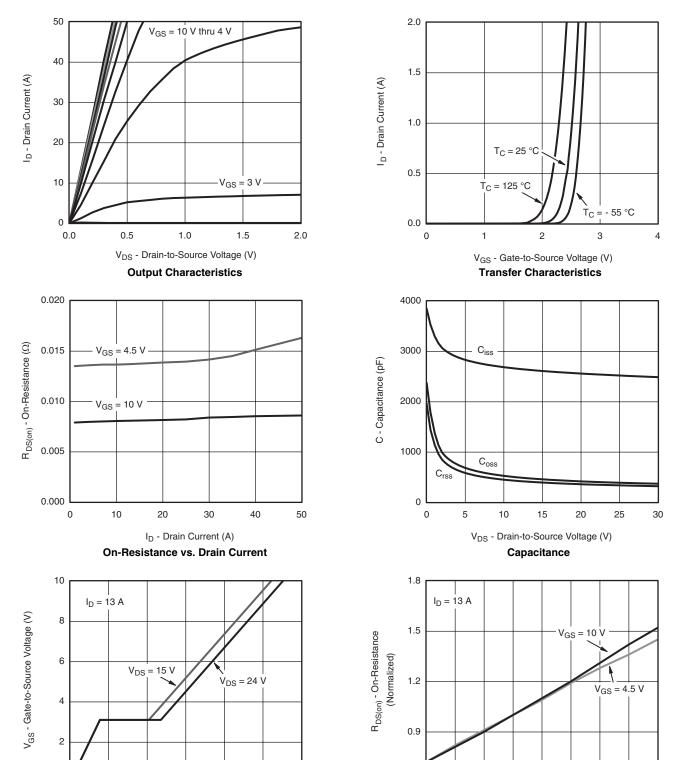
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$ 

b. Guaranteed by design, not subject to production testing.



### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



 $\label{eq:TJ-Junction} T_{J} \text{ - Junction Temperature (°C)}$  On-Resistance vs. Junction Temperature

50

75

100

0.6

- 50

- 25

0

25

0

0

10

30

Q<sub>q</sub> - Total Gate Charge (nC)

**Gate Charge** 

40

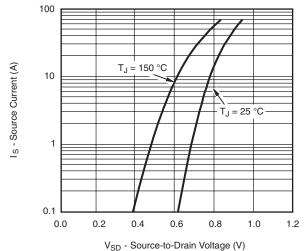
50

60

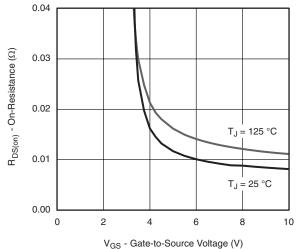
125

150

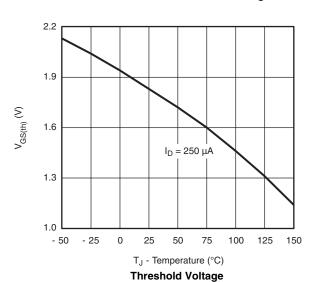
#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

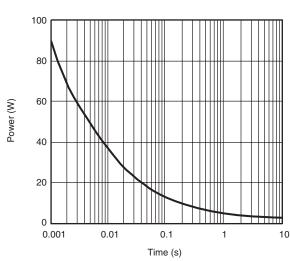


Source-Drain Diode Forward Voltage

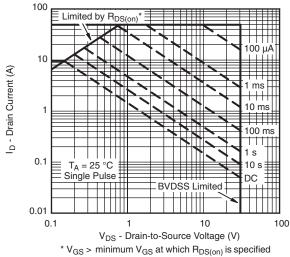


On-Resistance vs. Gate-to-Source Voltage



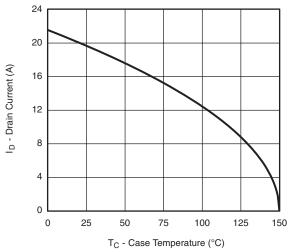


Single Pulse Power (Junction-to-Ambient)

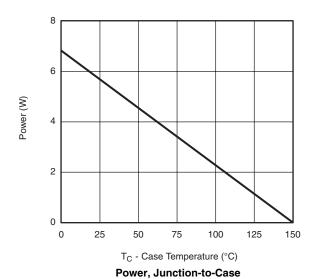


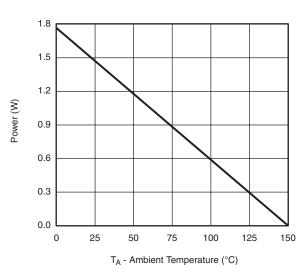
Safe Operating Area, Junction-to-Ambient

#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



#### **Current Derating\***





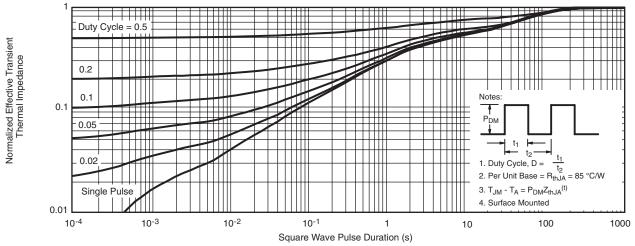
Power, Junction-to-Ambient

Document Number: 64732 S09-0314-Rev. A, 02-Mar-09

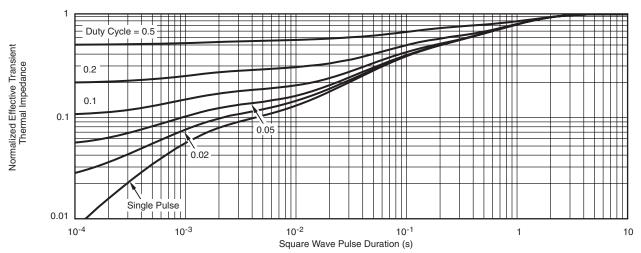
<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



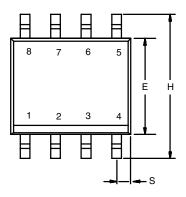
Normalized Thermal Transient Impedance, Junction-to-Ambient

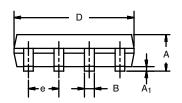


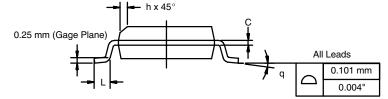
Normalized Thermal Transient Impedance, Junction-to-Foot



**SOIC (NARROW): 8-LEAD** JEDEC Part Number: MS-012



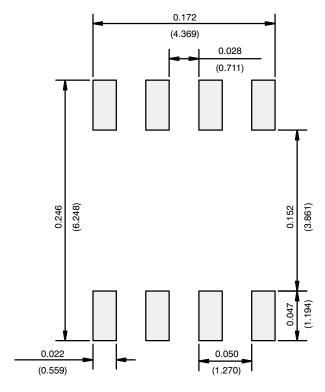




	MILLIM	IETERS	INCHES			
DIM	Min	Max	Min	Max		
Α	1.35	1.75	0.053	0.069		
A <sub>1</sub>	0.10	0.20	0.004	0.008		
В	0.35	0.51	0.014	0.020		
С	0.19	0.25	0.0075	0.010		
D	4.80	5.00	0.189	0.196		
Е	3.80	4.00	0.150	0.157		
е	1.27 BSC		0.050 BSC			
Н	5.80	6.20	0.228	0.244		
h	0.25	0.50	0.010	0.020		
L	0.50	0.93	0.020	0.037		
q	0°	8°	0°	8°		
S	0.44	0.64	0.018	0.026		
ECN: C-06527-Rev. I, 11-Sep-06						

DWG: 5498

#### **RECOMMENDED MINIMUM PADS FOR SO-8**



Recommended Minimum Pads Dimensions in Inches/(mm)

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